



ALPHA & OMEGA
SEMICONDUCTOR

AOW125A60/AOWF125A60
600V, α MOS5™ N-Channel Power Transistor

General Description

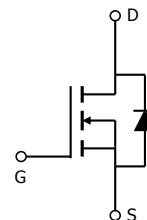
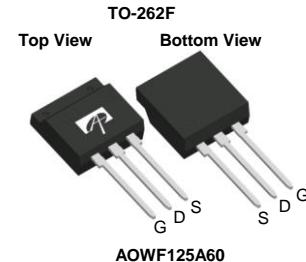
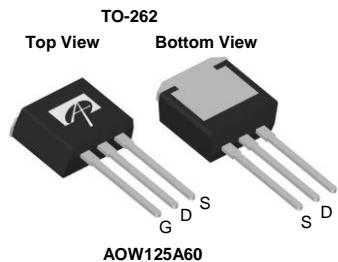
- Proprietary α MOS5™ technology
- Low $R_{DS(ON)}$
- Optimized switching parameters for better EMI performance
- Enhanced body diode for robustness and fast reverse recovery

Applications

- SMPS with PFC, Flyback and LLC topologies
- Micro inverter with DC/AC inverter topology

Product Summary

V_{DS} @ $T_{j,max}$	700V
I_{DM}	100A
$R_{DS(ON),max}$	< 0.125Ω
$Q_{g,typ}$	39nC
E_{oss} @ 400V	6.3μJ
100% UIS Tested	
100% R_g Tested	



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOW125A60	TO262	Tube	1000
AOWF125A60	TO262F	Tube	1000

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	AOW125A60	AOWF125A60	Units
Drain-Source Voltage	V_{DS}	600		V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	$I_C=25^\circ\text{C}$ $I_C=100^\circ\text{C}$	28	28*	A
Current		18	18*	
Pulsed Drain Current ^C	I_{DM}	100		
Avalanche Current ^C L=1mH	I_{AR}	7.9		A
Repetitive avalanche energy ^C	E_{AR}	31		mJ
Single pulsed avalanche energy ^G	E_{AS}	555		mJ
MOSFET dv/dt ruggedness	dv/dt	100		V/ns
Diode reverse recovery	dv/dt	20		V/ns
$V_{DS}=0$ to 400V, $I_F \leq 20\text{A}$, $T_J=25^\circ\text{C}$	di/dt	500		A/us
Power Dissipation ^B	$T_C=25^\circ\text{C}$	312.5	32.5	W
		2.5	0.25	W/ $^\circ\text{C}$
Junction and Storage Temperature Range	T_J , T_{STG}	-55 to 150		$^\circ\text{C}$
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300		$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	AOW125A60	AOWF125A60	Units
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	65	65	$^\circ\text{C/W}$
Maximum Case-to-sink ^A	$R_{\theta CS}$	0.5	---	$^\circ\text{C/W}$
Maximum Junction-to-Case	$R_{\theta JC}$	0.4	3.8	$^\circ\text{C/W}$

* Drain current limited by maximum junction temperature.

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =25°C	600			V
		I _D =250μA, V _{GS} =0V, T _J =150°C		700		
BV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D =250μA, V _{GS} =0V		0.51		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =600V, V _{GS} =0V		1		μA
		V _{DS} =480V, T _J =125°C		10		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	3.3	3.9	4.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =14A		0.108	0.125	Ω
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =14A		21		S
V _{SD}	Diode Forward Voltage	I _S =14A, V _{GS} =0V		0.86	1.2	V
I _S	Maximum Body-Diode Continuous Current				28	A
I _{SM}	Maximum Body-Diode Pulsed Current ^c				100	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		2993		pF
C _{oss}	Output Capacitance			85		pF
C _{o(er)}	Effective output capacitance, energy related ^H	V _{GS} =0V, V _{DS} =0 to 480V, f=1MHz		73		pF
C _{o(tr)}	Effective output capacitance, time related ^I			305		pF
C _{rss}	Reverse Transfer Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		0.8		pF
R _g	Gate resistance	f=1MHz		2.3		Ω
SWITCHING PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =480V, I _D =14A		39		nC
Q _{gs}	Gate Source Charge			19		nC
Q _{gd}	Gate Drain Charge			9		nC
t _{D(on)}	Turn-On Delay Time	V _{GS} =10V, V _{DS} =400V, I _D =14A, R _G =5Ω		39		ns
t _r	Turn-On Rise Time			34		ns
t _{D(off)}	Turn-Off Delay Time			56		ns
t _f	Turn-Off Fall Time			19		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =14A, dI/dt=100A/μs, V _{DS} =400V		375		ns
I _{rm}	Peak Reverse Recovery Current			34		A
Q _{rr}	Body Diode Reverse Recovery Charge			8		μC

A. The value of R_{0JA} is measured with the device in a still air environment with T_A=25°C.

B. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and duty cycles to keep initial T_J=25°C.

D. The R_{0JA} is the sum of the thermal impedance from junction to case R_{0JC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

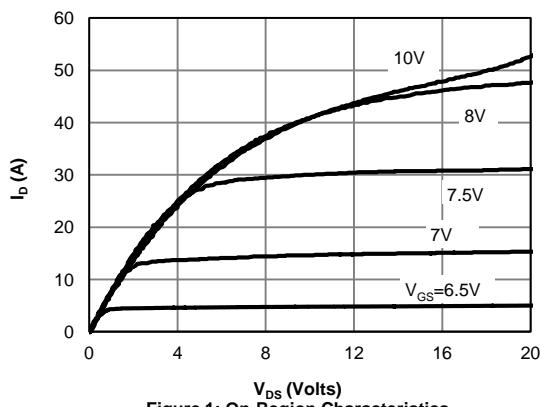
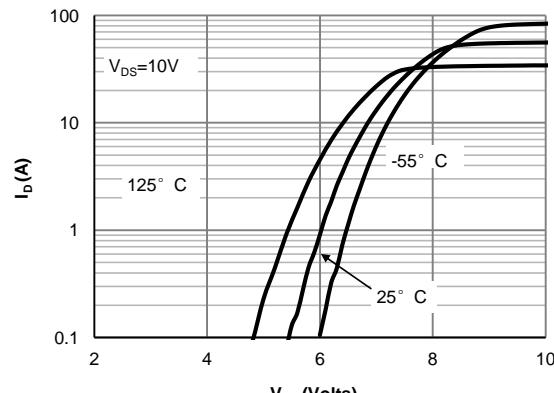
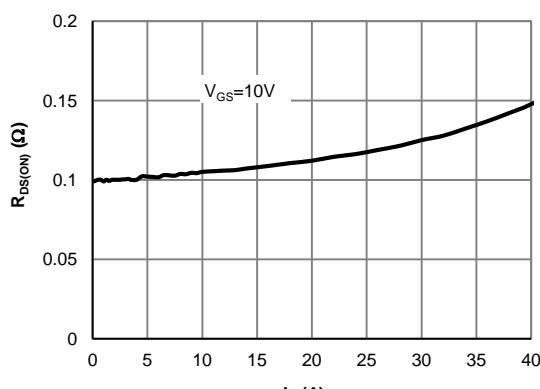
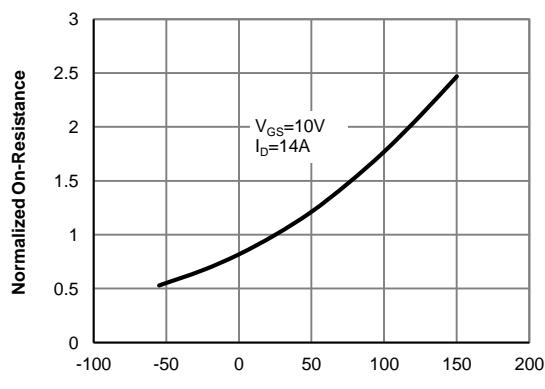
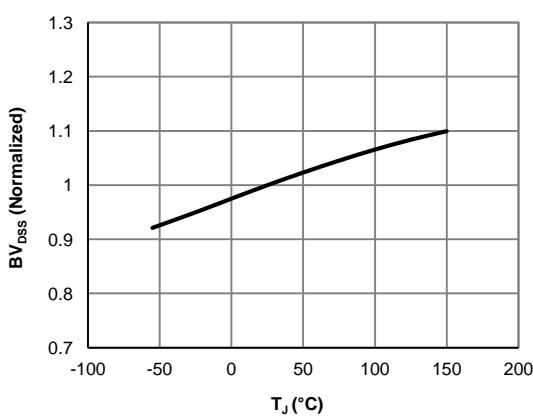
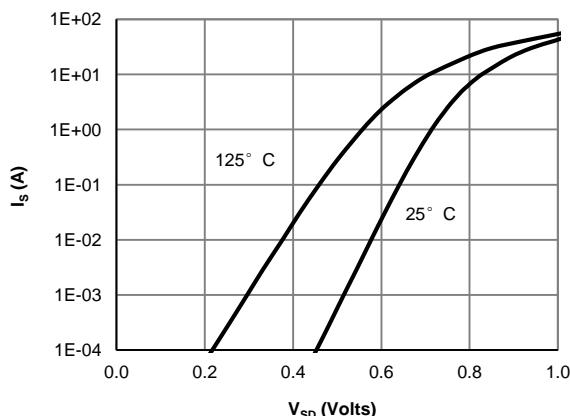
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.

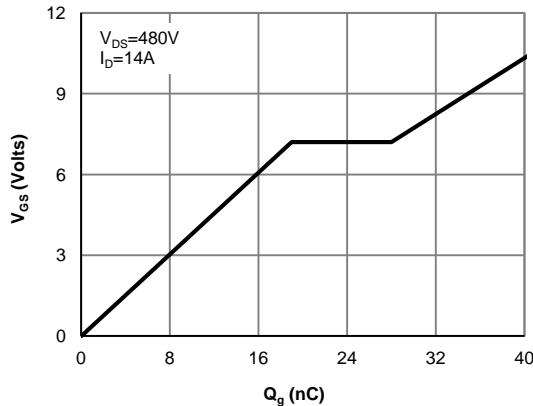
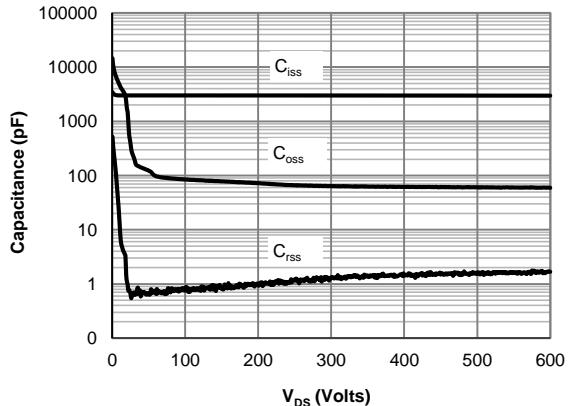
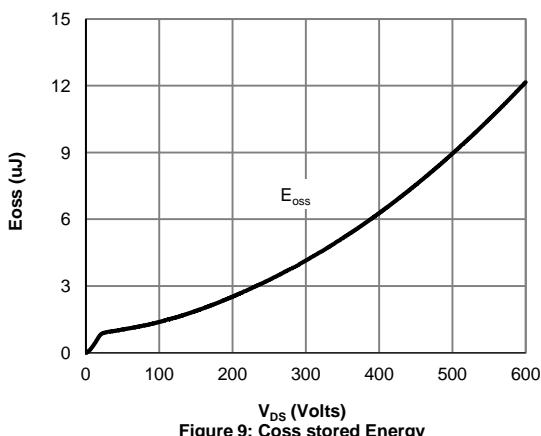
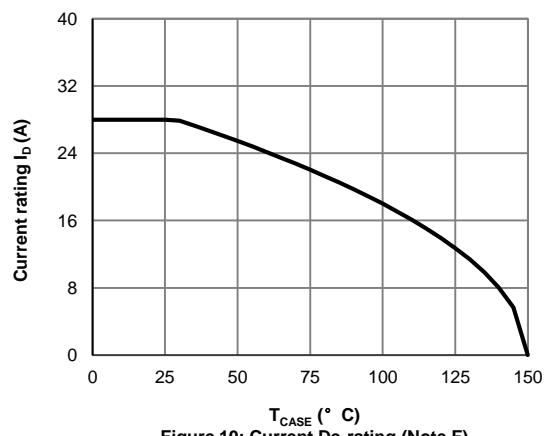
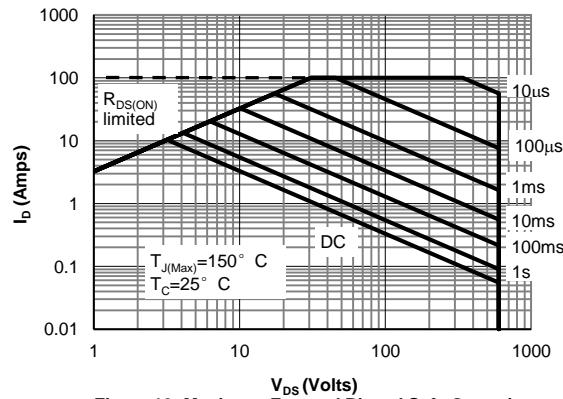
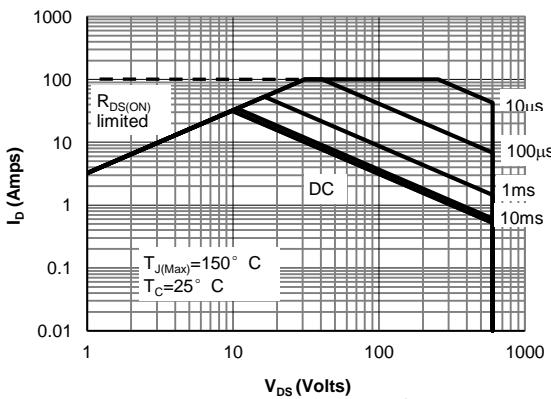
G. L=60mH, I_{AS}=4.3A, R_G=25Ω, Starting T_J=25°C.

H. C_{o(er)} is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

I. C_{o(tr)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5: Break Down vs. Junction Temperature

Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Coss stored Energy

Figure 10: Current De-rating (Note F)


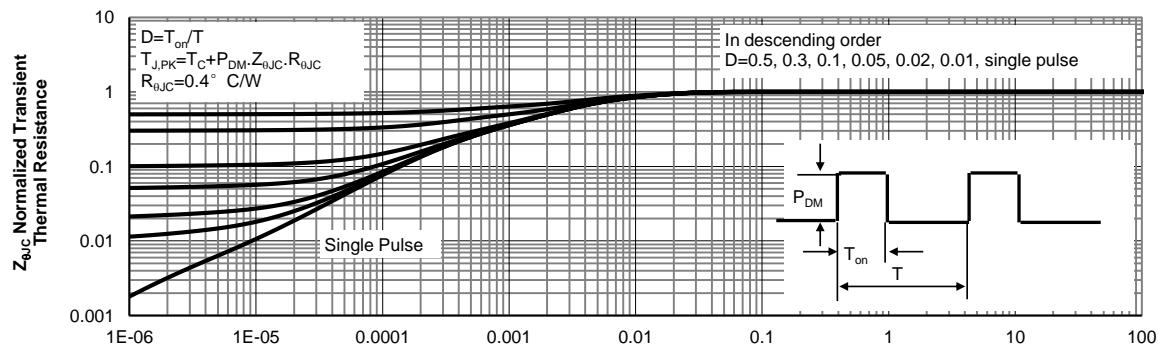
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Figure 13: Normalized Maximum Transient Thermal Impedance for AOW125A60 (Note F)

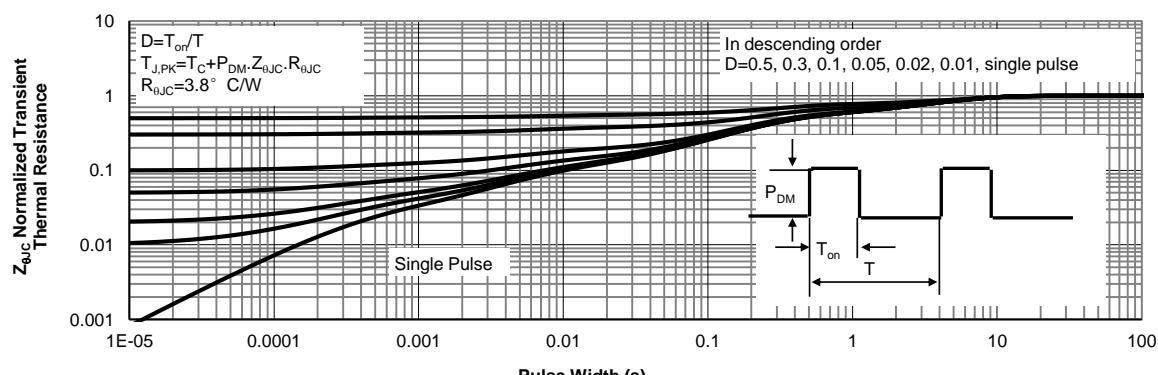


Figure 14: Normalized Maximum Transient Thermal Impedance for AOWF125A60 (Note F)

